

Search Notes

Application/Control No.

10/692,270

Examiner

Dinh Q. Nguyen

Applicant(s)/Patent under
Reexamination

KOLACZ ET AL.

Art Unit

3752

SEARCHED

Class	Subclass	Date	Examiner
239	587.1-		
	587.6		
↓	588	" 14/05	DN
169	24		
↓	25		
↓	52	" 14/05	DN
285	261-		
↓	267		
↓	185	" 14/05	DN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
REF 09/516,076	" 14/05	DN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner